

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination TANEDA ET AL.	
		Examiner Tiffany L. Webb	Art Unit 3616	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-4,796,911	01-1989	Kuroki et al.	280/5.511
*	B US-6,457,730	10-2002	Urbach, Brian A.	280/124.161
*	C US-6,805,361	10-2004	Germano et al.	280/5.511
*	D US-6,698,767	03-2004	Hagan, Daniel Lee	280/5.511
*	E US-6,428,019	08-2002	Kincad et al.	280/5.511
*	F US-2002/0121748	09-2002	Ignatius et al.	280/5.511
*	G US-2002/0113393	08-2002	Urbach, Brian A.	280/124.106
*	H US-2002/0180167	12-2002	Schmidt et al.	280/5.511
*	I US-2004/0217560	11-2004	Heller et al.	280/005.502
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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